

**Notice of References Cited**

Application/Control No.

10/726,443

Applicant(s)/Patent Under  
Reexamination  
AZUMA, SHIGEO

Examiner

Douglas C. Godbold

Art Unit

2626

Page 1 of 2

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,295,068 A	03-1994	Nishino et al.	704/10
*	B	US-5,349,368 A	09-1994	Takeda et al.	345/684
*	C	US-5,535,120 A	07-1996	Chong et al.	704/3
*	D	US-5,826,220 A	10-1998	Takeda et al.	704/7
*	E	US-5,844,798 A	12-1998	Uramoto, Naohiko	704/2
*	F	US-5,893,901 A	04-1999	Maki, Kazuhiko	704/260
*	G	US-5,987,401 A	11-1999	Trudeau, John R.	704/2
*	H	US-6,161,082 A	12-2000	Goldberg et al.	704/3
*	I	US-2002/0021307 A1	02-2002	Glenn et al.	345/753
*	J	US-2002/0065647 A1	05-2002	Hatori et al.	704/2
*	K	US-2003/0046062 A1	03-2003	Cartus, John R.	704/10
*	L	US-6,535,842 B1	03-2003	Roche et al.	704/7
*	M	US-2003/0125927 A1	07-2003	Seme, Yonas D.	704/3

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

<b>Notice of References Cited</b>	Application/Control No. 10/726,443	Applicant(s)/Patent Under Reexamination AZUMA, SHIGEO	
	Examiner Douglas C. Godbold	Art Unit 2626	Page 2 of 2

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0154069 A1	08-2003	Carew et al.	704/7
*	B	US-6,708,205 B2	03-2004	Sheldon et al.	709/206
*	C	US-6,789,057 B1	09-2004	Morimoto et al.	704/2
*	D	US-2004/0205674 A1	10-2004	Delgado et al.	715/536
*	E	US-6,876,963 B1	04-2005	Miyahira et al.	704/4
*	F	US-7,031,906 B2	04-2006	Shimohata et al.	704/2
*	G	US-7,155,173 B2	12-2006	Leung et al.	455/72
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.